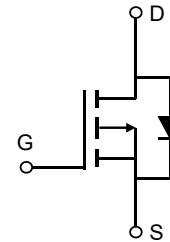


### Description

#### Features

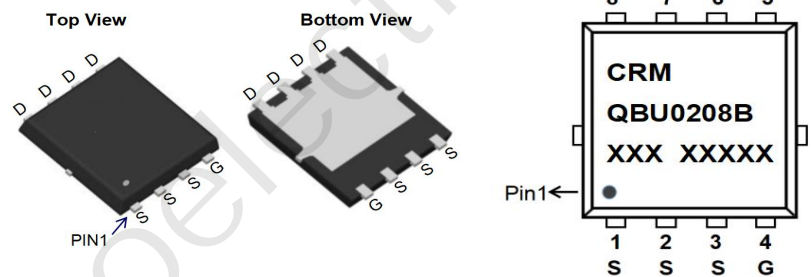
- -20V, -55A  
 $R_{DS(ON)}$  Typ = 5.8mΩ @  $V_{GS} = -4.5V$   
 $R_{DS(ON)}$  Typ = 7.8mΩ @  $V_{GS} = -2.5V$
- Advanced Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead Free
- 100% UIS TESTED!
- 100%  $\Delta V_d$ s TESTED!



Schematic Diagram

#### Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

#### Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMQBU0208B	CRMQBU0208B	PDFN3.3x3.3-8L	TAPING	13"	5000	50000

#### Absolute Maximum Ratings (@ $T_J = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Units
$V_{DS}$	Drain-to-Source Voltage	-20	V
$V_{GS}$	Gate-to-Source Voltage	±12	V
$I_D$	Continuous Drain Current	$T_C = 25^\circ C$	-55
		$T_C = 100^\circ C$	-35
$I_{DM}$	Pulsed Drain Current <sup>(1)</sup>	-220	A
$E_{AS}$	Single Pulsed Avalanche Energy <sup>(2)</sup>	43	mJ
$P_D$	Power Dissipation	$T_C = 25^\circ C$	42
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3	°C/W
$T_J, T_{STG}$	Junction & Storage Temperature Range	-55 to 150	°C

### Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V	-20	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V	-	-	-1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±12V	-	-	±100	nA
<b>On Characteristics</b>						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	-0.4	-0.65	-1	V
R <sub>DS(ON)</sub>	Static Drain-Source ON-Resistance <sup>(3)</sup>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -15A	-	5.8	7.6	mΩ
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -10A	-	7.8	10	mΩ
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = -10V, f = 1MHz	-	2839	-	pF
C <sub>oss</sub>	Output Capacitance		-	372	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	311	-	pF
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> = 0 to -4.5V V <sub>DS</sub> = -10V, I <sub>D</sub> = -15A	-	54	-	nC
Q <sub>gs</sub>	Gate Source Charge		-	7	-	nC
Q <sub>gd</sub>	Gate Drain("Miller") Charge		-	14	-	nC
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> = -10V, V <sub>DD</sub> = -10V I <sub>D</sub> = -13A, R <sub>GEN</sub> = 3Ω	-	13	-	ns
t <sub>r</sub>	Turn-On Rise Time		-	105	-	ns
t <sub>d(off)</sub>	Turn-Off DelayTime		-	145	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	150	-	ns
<b>Drain-Source Diode Characteristics and Max Ratings</b>						
I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current		-	-	-55	A
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-220	A
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = -10A	-	-	-1.2	V
trr	Body Diode Reverse Recovery Time	I <sub>F</sub> = -15A, di/dt = 100A/us	-	26	-	ns
Qrr	Body Diode Reverse Recovery Charge		-	15	-	nC

- Notes:
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
  2. E<sub>AS</sub> condition: Starting T<sub>J</sub>=25°C, V<sub>DD</sub>=-10V, V<sub>G</sub>=-10V, R<sub>G</sub>=25ohm, L=0.5mH, I<sub>AS</sub>=-13A
  3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 0.5%.

### Typical Performance Characteristics

Figure 1: Output Characteristics

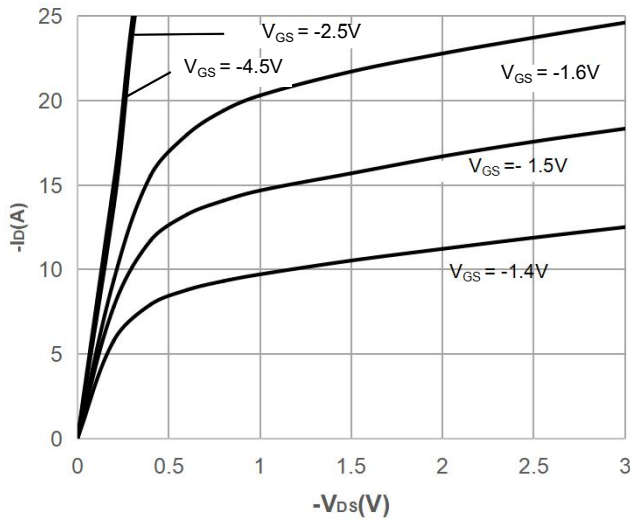


Figure 2: Typical Transfer Characteristics

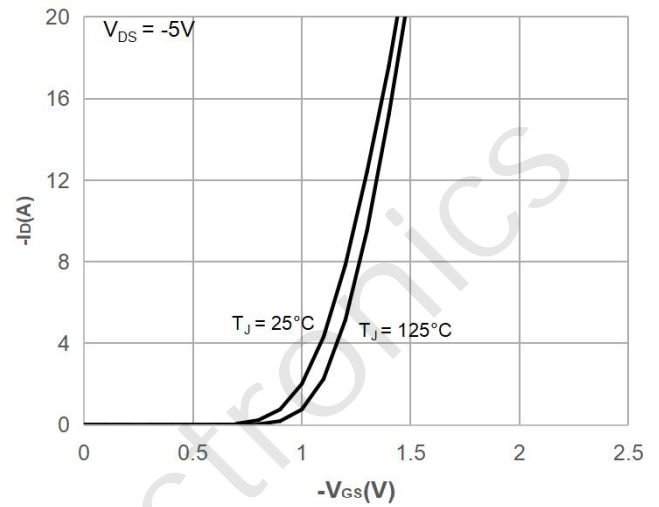


Figure 3: On-resistance vs. Drain Current

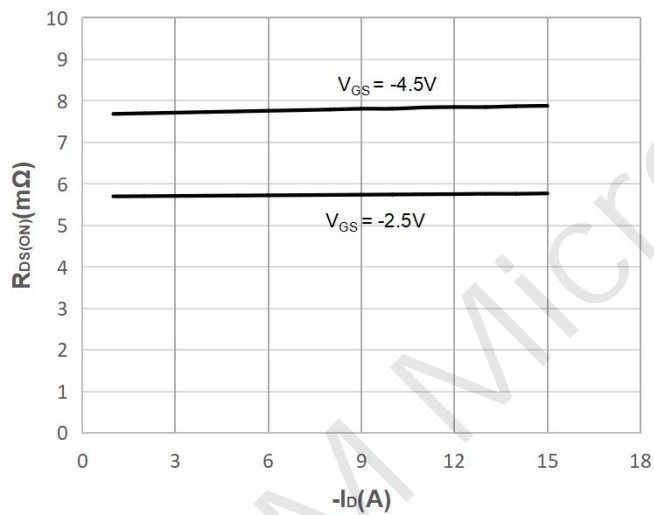


Figure 4: Body Diode Characteristics

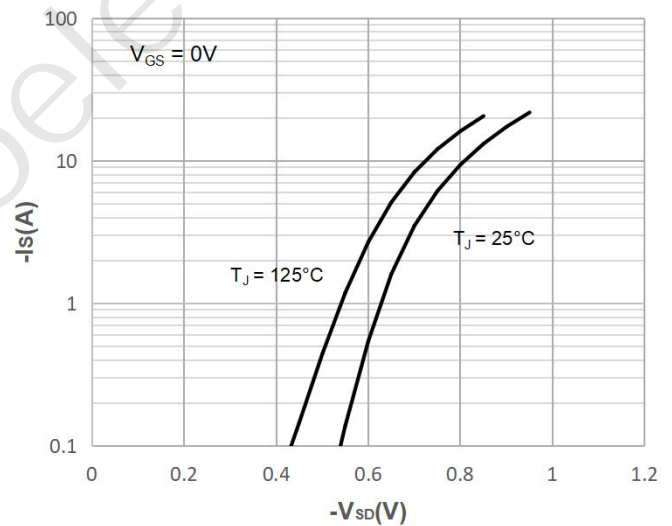


Figure 5: Gate Charge Characteristics

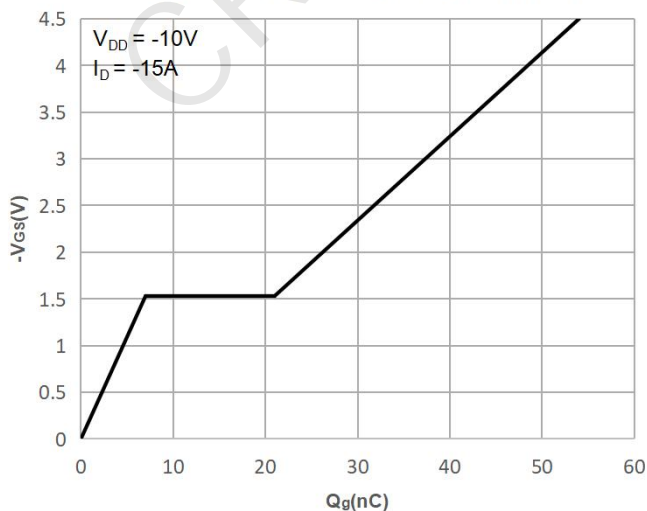
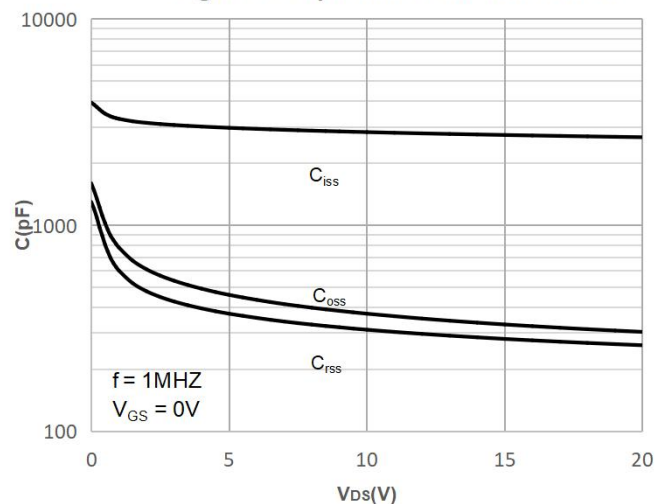


Figure 6: Capacitance Characteristics



### Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs. Junction Temperature

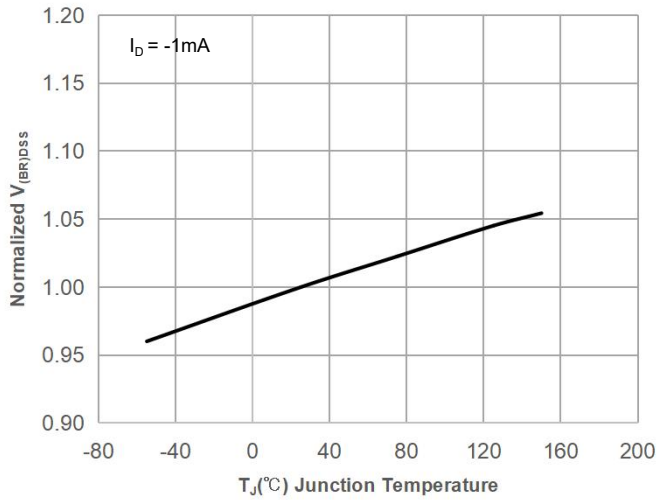


Figure 8: Normalized on Resistance vs. Junction Temperature

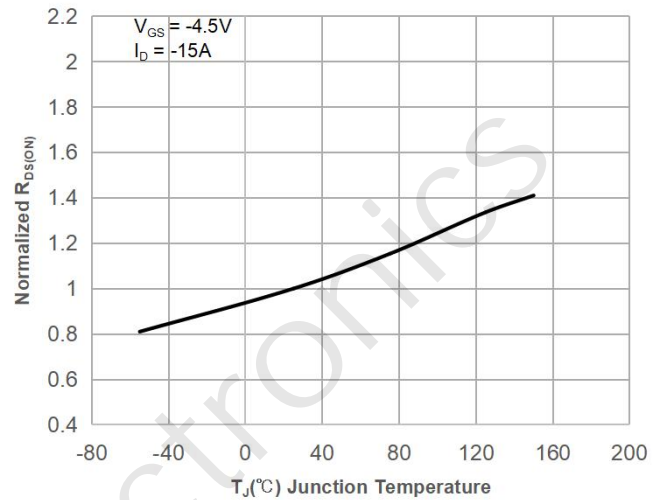


Figure 9: Maximum Safe Operating Area

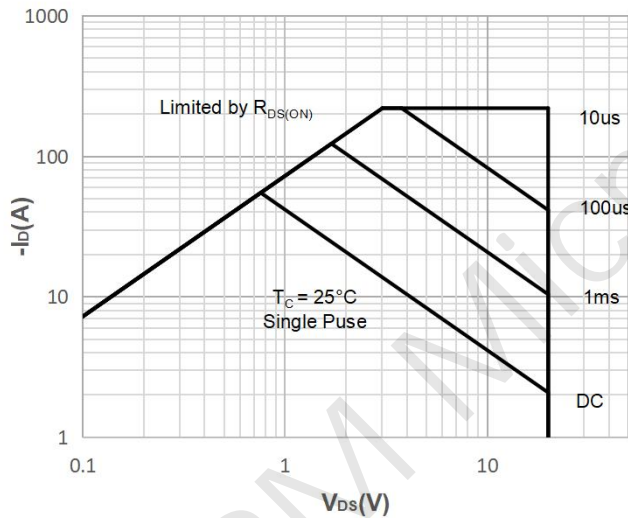


Figure 10: Maximum Continuous Driand Current vs. Case Temperature

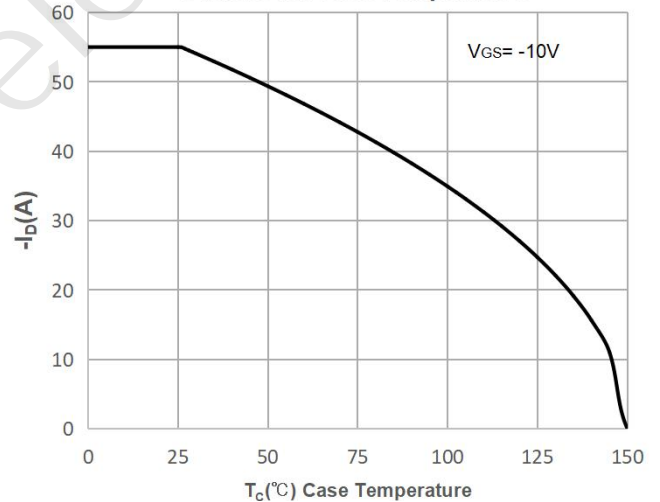


Figure 11: Normalized Maximum Transient Thermal Impedance

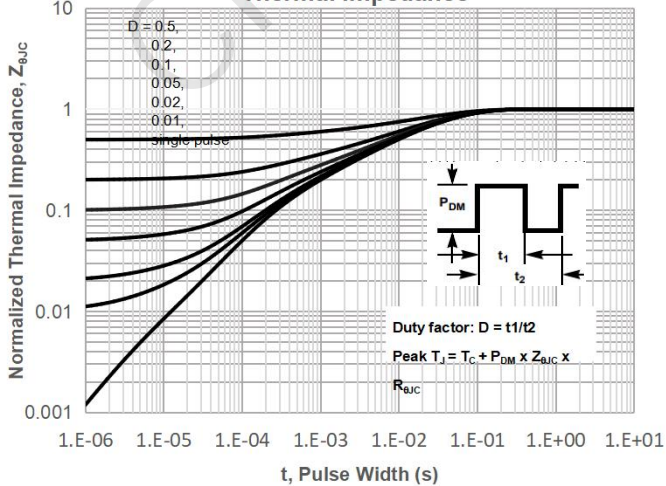
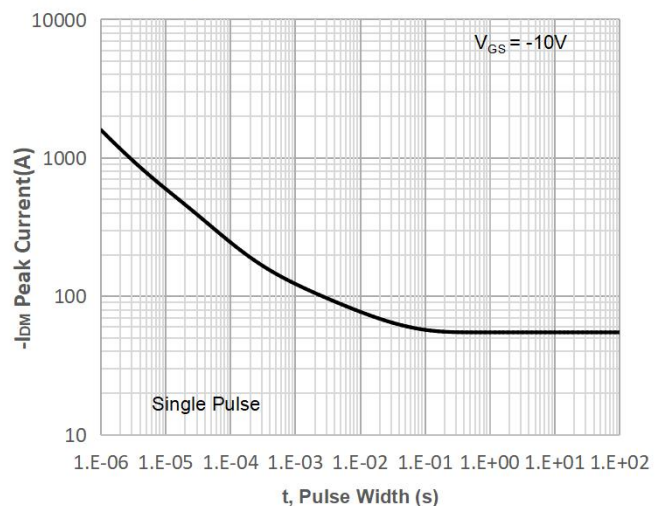
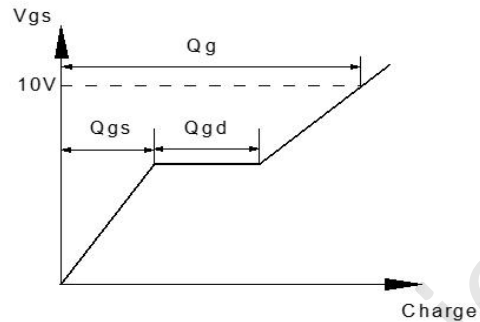
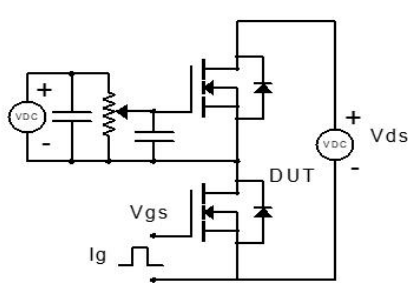


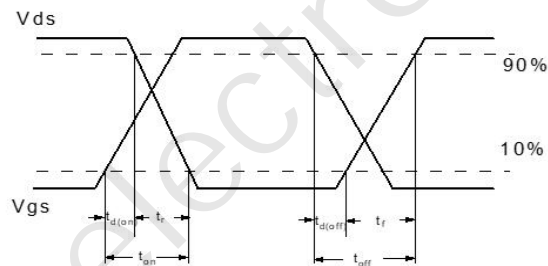
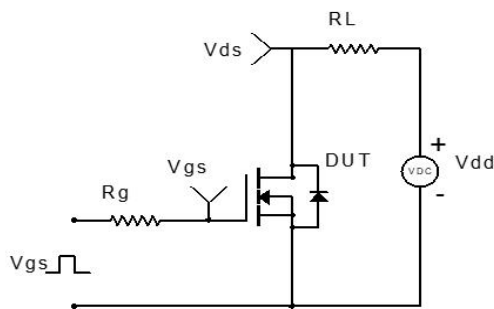
Figure 12: Peak Current Capacity



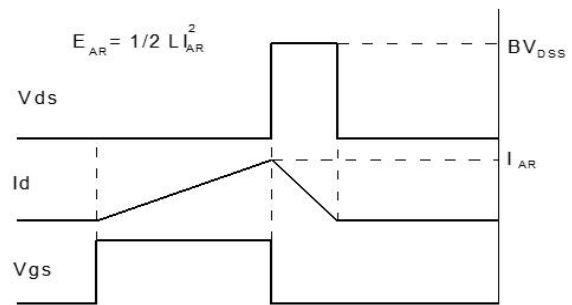
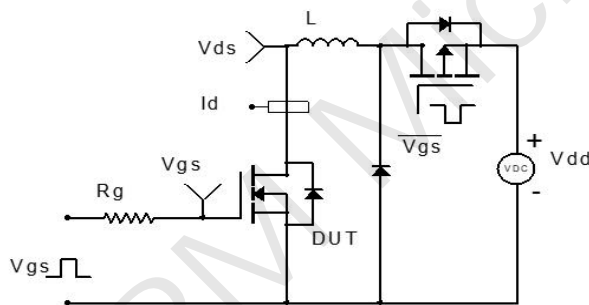
**Test Circuit**



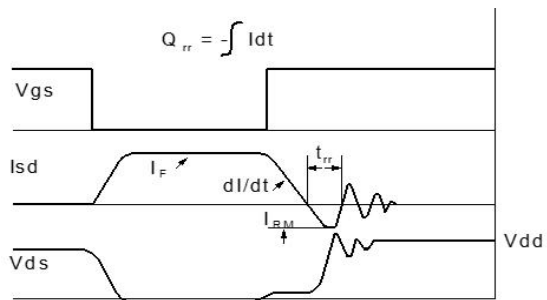
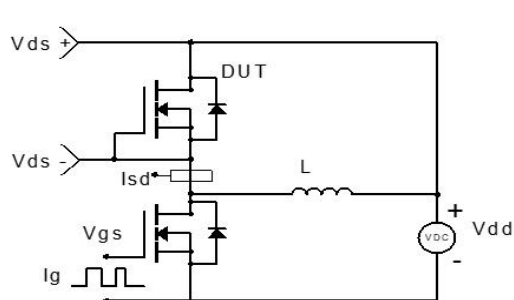
**Figure 1: Gate Charge Test Circuit & Waveform**



**Figure 2: Resistive Switching Test Circuit & Waveform**

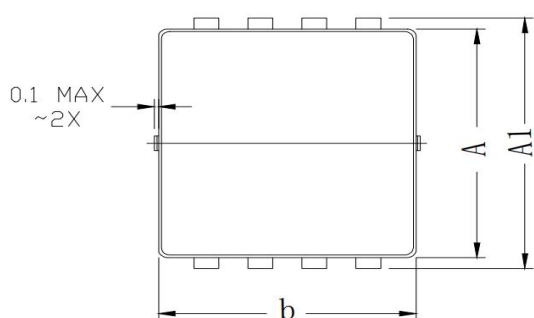
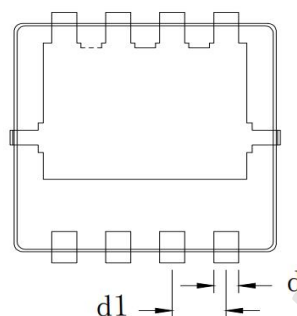
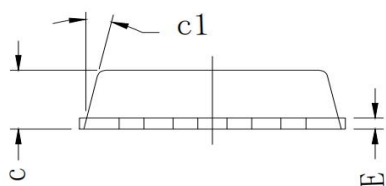


**Figure 3: Unclamped Inductive Switching Test Circuit & Waveform**



**Figure 4: Diode Recovery Test Circuit & Waveform**

### Package Mechanical Data(PDFN3.3x3.3-8L)




COMMON DIMENSION (MM)			
PKG	PDFN 3×3		
Symbol	MIN	MON	MAX
A	3.070	3.100	3.130
A1	3.300	3.400	3.500
b	3.070	3.100	3.130
c	0.770	0.800	0.830
c1	13°		
d	0.300		
d1	0.650		
E	0.152		

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